

Notice of References Cited			Application/Control No. 10/091,859	Applicant(s)/Patent Under Reexamination ADLER, RICHARD M.	
			Examiner Nathan Erb	Art Unit 3639	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,247,651 A	09-1993	Clarissee, Olivier B. H.	703/13
*	B	US-5,761,486 A	06-1998	Watanabe et al.	703/21
*	C	US-5,850,538 A	12-1998	Steinman, Jeffrey S.	703/21
*	D	US-5,953,707 A	09-1999	Huang et al.	705/10
*	E	US-6,212,502 B1	04-2001	Ball et al.	704/270
*	F	US-6,321,205 B1	11-2001	Eder, Jeff	705/7
*	G	US-6,327,574 B1	12-2001	Kramer et al.	705/14
*	H	US-2001/0053991 A1	12-2001	Bonabeau, Eric W.	705/7
*	I	US-2002/0065701 A1	05-2002	Kim et al.	705/9
*	J	US-6,405,173 B1	06-2002	Honarvar et al.	705/7
*	K	US-2002/0099598 A1	07-2002	Eicher et al.	705/11
*	L	US-6,990,437 B1	01-2006	Abu El Ata, Nabil A.	703/2
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.